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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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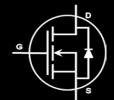




EPC2016 – Enhancement Mode Power Transistor

 \overline{V}_{DSS} , $\overline{100}\,\overline{V}$ $R_{DS(ON)}$, $\overline{16}\,\overline{m}\Omega$ \overline{I}_{D} , $\overline{11}\,\overline{A}$

NEW PRODUC

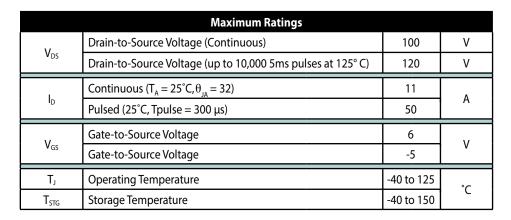








Gallium Nitride is grown on Silicon Wafers and processed using standard CMOS equipment leveraging the infrastructure that has been developed over the last 55 years. GaN's exceptionally high electron mobility and low temperature coefficient allows very low $R_{\rm DS(ON)}$, while its lateral device structure and majority carrier diode provide exceptionally low $Q_{\rm G}$ and zero $Q_{\rm RR}$. The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.





EPC2016 eGaN® FETs are supplied only in passivated die form with solder bars

Applications

- High Speed DC-DC conversion
- Class D Audio
- Hard Switched and High Frequency Circuits

Benefits

- · Ultra High Efficiency
- Ultra Low R_{DS(on)}
- Ultra low Q_G
- · Ultra small footprint

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Static Characte	tatic Characteristics (T _j = 25°C unless otherwise stated)						
BV_{DSS}	Drain-to-Source Voltage	$V_{GS} = 0 \text{ V}, I_D = 200 \mu\text{A}$	100			V	
I _{DSS}	Drain Source Leakage	$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$		25	150	μΑ	
1	Gate-Source Forward Leakage	$V_{GS} = 5 \text{ V}$		0.5	3	mA	
I _{GSS}	Gate-Source Reverse Leakage	$V_{GS} = -5 \text{ V}$		0.1	0.5		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 3 \text{ mA}$	0.7	1.4	2.5	V	
R _{DS(ON)}	Drain-Source On Resistance	$V_{GS} = 5 \text{ V, } I_D = 11 \text{ A}$		12	16	mΩ	
Source-Drain Characteristics (T _j = 25°C unless otherwise stated)							
V	Source-Drain Forward Voltage	$I_S = 0.5 \text{ A}, V_{GS} = 0 \text{ V}, T = 25^{\circ}\text{C}$		1.68		V	
V_{SD}		$I_S = 0.5 \text{ A}, V_{GS} = 0 \text{ V}, T = 125^{\circ}\text{C}$		1.73]	

All measurements were done with substrate shorted to source.

Thermal Characteristics				
		ТҮР		
$R_{\theta JC}$	Thermal Resistance, Junction to Case	3.6	°C/W	
$R_{\theta JB}$	Thermal Resistance, Junction to Board	19	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1)	69	°C/W	

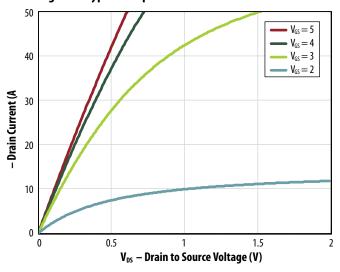
Note 1: R_{BLA} is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board.

See http://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details.

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Dynamic Chara	Dynamic Characteristics (T _j = 25°C unless otherwise stated)						
C _{ISS}	Input Capacitance			433	520		
Coss	Output Capacitance	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}$		225	280	pF	
C _{RSS}	Reverse Transfer Capacitance			4.3	6		
Q_{G}	Total Gate Charge (V _{GS} = 5 V)			3.8	5.2		
Q_{GD}	Gate to Drain Charge	V - 50V I - 11 A		0.70	1.4		
Q_{GS}	Gate to Source Charge	$V_{DS} = 50 \text{ V, } I_{D} = 11 \text{ A}$		0.99	1.5	nC	
Q _{oss}	Output Charge			20	30		
Q_{RR}	Source-Drain Recovery Charge			0	0		

All measurements were done with substrate shorted to source.

Figure 1: Typical Output Characteristics



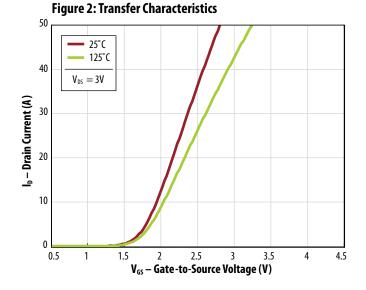


Figure 3: R_{DS(on)} vs V_{GS} for Various Drain Currents

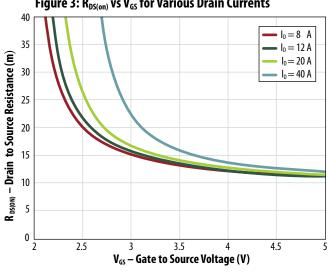
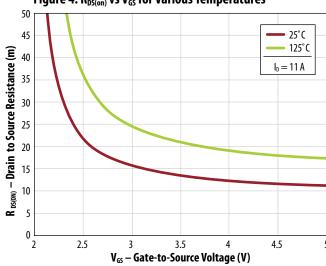
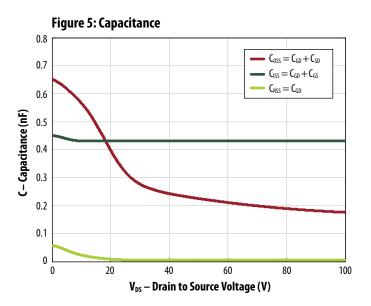


Figure 4: $R_{DS(on)}$ vs V_{GS} for Various Temperatures





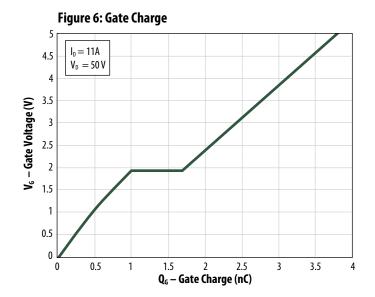


Figure 7: Reverse Drain-Source Characteristics

50

40

25°C

125°C

10

0

0

0

0

0

1.5

2.5

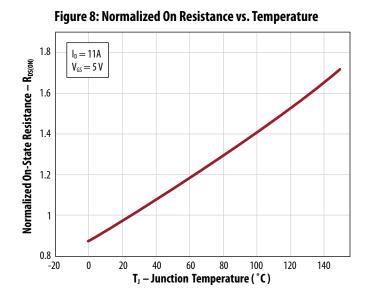
2.5

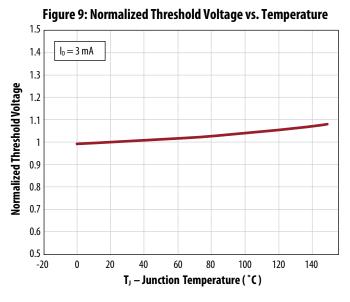
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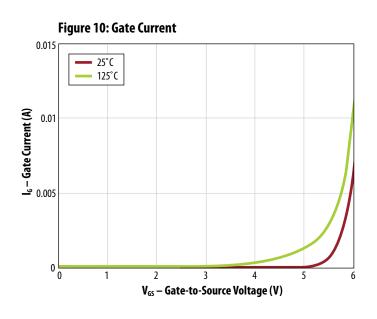
3.5

4

V_{so} – Source to Drain Voltage (V)

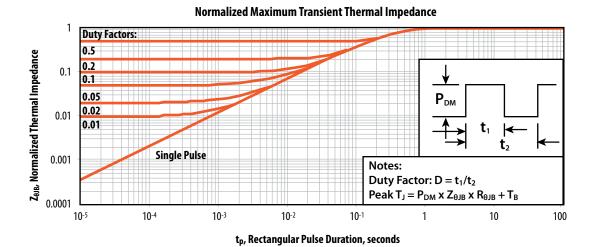






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Figure 11: Transient Thermal Response Curves



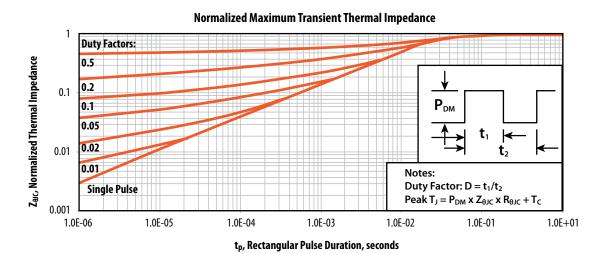
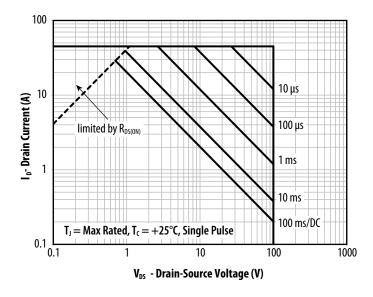
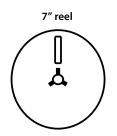


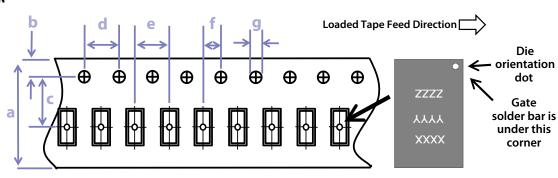
Figure 12: Safe Operating Area



TAPE AND REEL CONFIGURATION

4mm pitch, 8mm wide tape on 7" reel



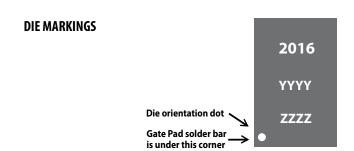


	EPC2016 (note 1)		
Dimension (mm)	target	min	max
a	8.00	7.90	8.30
b	1.75	1.65	1.85
c (see note)	3.50	3.45	3.55
d	4.00	3.90	4.10
e	4.00	3.90	4.10
f (see note)	2.00	1.95	2.05
q	1.5	1.5	1.6

Die is placed into pocket solder bar side down (face side down)

Note 1: MSL1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.

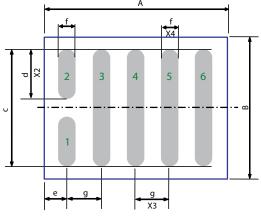
Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.



Dort	Laser Markings			
Part Number	Part # Marking Line 1	Lot_Date Code Marking line 2	Lot_Date Code Marking Line 3	
EPC2016	2016	YYYY	ZZZZ	

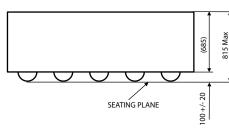
DIE OUTLINE

Solder Bar View



DIM	MICROMETERS				
DIM	MIN	Nominal	MAX		
A	2076	2106	2136		
В	1602	1632	1662		
C	1379	1382	1385		
d	577	580	583		
e	235	250	265		
f	195	200	205		
q	400	400	400		

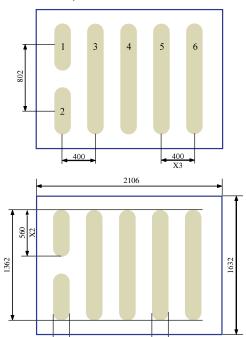
Side View



RECOMMENDED LAND PATTERN

(units in µm)

The land pattern is solder mask defined.



180

180

Pad no. 1 is Gate;

Pads no. 3, 5 are Drain;

Pads no. 4, 6 are Source;

Pad no. 2 is Substrate.

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U.S. Patents 8,350,294; 8,404,508; 8,431,960; 8,436,398

Information subject to change without notice.
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